Approved For Rele	ase_2903/05/15 : CIA-RDP78B04747A00300 90 20028-7	STAT
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	552 MDRI PRODUCT IMPROVEMENT UTILIZING	STAT
	OPTISYN Encoders	
	e capability and flexibility of present 552	
Stereo Viewer by r	modifying same to include automatic digital	
		STAT
	Project Engineer	¥
	+ # _{1.2}	
Declass Review by NIMA / D	OoD	· g

	GENERAL		STAT
			havo
	The 552 Point 1	Marking System will be modified to	+ evetam
	Automatic Comparator-Men	suration capability. A measuremen	
	employing	OPTISYN encoders	· ·
AT	Solid State count	ers, shielded cables of proper ler	gtn,
		ord provisions will be supplied by	stae STAT
	customer for installatio	n	SIAI
3 ,			
	Automatic X-Y	coordinate measurements of photo	points
7.	are obtained through end	oders attached to precision lead	screws.
	supplied	Panel Controls will permit zero	reset, SIAI
4	data printout/recording	on demand. Any extra data entry	switches
	will be supplied by cust	omer for installation on the cont	rol
	panel.		
1			
· ·	SCREWS		
	-		
	Precision grou	and ball lead screws 2 1/2mm pitch	; one
	(1) micron per inch max:	imum lead error, five (5) microns	per foot
		Maximum lead error including th	
		n is expected to be better than $1/$	
		·	
Ą	ENCODERS		*
	Four (4) incr	emental photo optical type encoder	s, manu-
١T	factured by	will be employed. Each will	
		tion, or a one (1) micron bit size	with an
	·	of + 1/4 micron, (according to ma	
	•		
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The size of these encoders, approximately 2 3/4 diameter by 2 1/4 inch length, will also require modification of the systems' X and Y carriage and base castings as explained in the Work Statement below. In addition, the standard encoder connector must be replaced by a potted pig tail arrangement to avoid lateral interferences.

READOUT, LOGIC AND DISPLAYS

NOTE:

To be supplied by customer, will contain six (6) digit counters, registers, and visual displays with provisions for recording measured data and extra identification data on printout equipment. Each axis will have a six (6) digit numerical display, the least significant count representing a one (1) micron bit.

Customer will provide shielded cables of a length specified by connectors and closures to house these components.

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NOTE: A count rate capacity of approximately 25kc is required. Also, zero reset switches should be provided for each axis on the individual counter display panels.

LIFE EXPECTANCY OF ENCODERS

The manufacturer's expected average mean time to failure of this optical type encoder is six (6) years and is dependent upon the life of the lamps and precision Ball Bearings. This charly exceeds the maintenance free life expectancy of Brush type encoders.

will provide ON-OFF power switch, data readout and zero reset switch at the operator's control panel. power 110/120 volts A.C. 60 cycles. Customer to supply cables from equipment to readout and counters. SYSTEM PERFORMANCE Digit bit size - one (1) micron. Naxiana speed 1/2 inch to 3/4 inch per second, approximately. ACCURACY STAT ACCURACY STAT Accuracy STAT Accuracy STAT System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long istance measurement goal is to provide an accuracy better than 2 1/2 microns plus .005; of distance travelled. On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: 2 1/2 microns or + 1 1/4 microns up to millimeters. System Accuracy: 2 1/2 microns or + 1 3/4 microns up to over distance travelled.	CONTROL		STAT
pigit bit size - one (1) micron. Naxiana speed 1/2 inch to 3/4 inch per second, approximately. ACCURACY STAT design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy oetter than 2 1/2 microns plus .005% of distance travelled. On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: 2 1/2 microns or + 1 1/4 microns up to 20 millimeters. System Accuracy: 2 1/2 microns up to 20 millimeters.	readout a	nd zero reset switch at the operator's control panel. 1/120 volts A.C. 60 cycles. Customer to supply cables	
Digit bit size - one (1) micron. Maximum speed 1/2 inch to 3/4 inch per second, approximately. ACCURACY STAT design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy petter than 2 1/2 microns plus 0.005, of distance travelled. On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: (1) 3 1/2 microns or + 1 1/4 microns up to 20 millimeters.		equipment to readout and counters.	2 1
Digit bit size - one (1) micron. Maximum speed 1/2 inch to 3/4 inch per second, approximately. ACCURACY STAT design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy petter than 2 1/2 microns plus 0.005, of distance travelled. On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: (1) 3 1/2 microns or + 1 1/4 microns up to 20 millimeters.	·	•	
Digit bit size - one (1) micron. Maximum speed 1/2 inch to 3/4 inch per second, approximately. ACCURACY STAT design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy petter than 2 1/2 microns plus 0.005, of distance travelled. On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: (1) 3 1/2 microns or + 1 1/4 microns up to 20 millimeters.	SYSTEM PE	ERFORMANCE	
ACCURACY STAT design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long istance measurement goal is to provide an accuracy better than 2 1/2 microns plus .005% of distance travelled. [LLEGIB] On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: (1) 3 1/2 microns or + 1 1/4 microns up to 20 millimeters. (2) System Accuracy: (2 1/2 microns + .005%)			
ACCURACY STAT design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long istance measurement goal is to provide an accuracy better than 2 1/2 microns plus .005% of distance travelled. [LLEGIB] On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: (1) 3 1/2 microns or + 1 1/4 microns up to 20 millimeters. (2) System Accuracy: (2 1/2 microns + .005%)		Digit bit size - one (1) micron.	
ACCURACY design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy petter than 2 1/2 microns plus 2005, of distance travelled. ILLEGIB On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: 2 1/2 microns or + 1 1/4 microns up to 20 millimeters. System Accuracy: 2 1/2 microns + .005%	3	Maximum speed 1/2 inch to 3/4 inch per second, approxi	mately.
design objective is to provide the 552 System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy oetter than 2 1/2 microns plus .005% of distance travelled. Contact			
System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long istance measurement goal is to provide an accuracy petter than 2 1/2 microns plus 005% of distance travelled. On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: 2 1/2 microns or + 1 1/4 microns up to 1 millimeter. (1) 3 1/2 microns or + 1 3/4 microns up to 20 millimeters.	ACCUDACY		STAT
System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy petter than 2 1/2 microns plus .005% of distance travelled. Control of the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT	ACCORNET		1 S 1 S 1 S 1 S 1 S 1 S 1 S 1 S 1 S 1 S
System with a repeatability of one (1) micron and an average measurement accuracy of approximately one (1) micron over short distances. Long instance measurement goal is to provide an accuracy petter than 2 1/2 microns plus .005% of distance travelled. Control of the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT		design objective is to provide the 55	2
measurement accuracy of approximately one (1) micron over short distances. Long istance measurement goal is to provide an accuracy petter than 2 1/2 microns plus .005% of distance travelled. ILLEGIB On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. Specified System Total Accuracy: 2 1/2 microns up to 1 millimeter. 3 1/2 microns or + 1 3/4 microns up to 2 millimeters. 3 1/2 microns or + 1 3/4 microns up to 2 millimeters. 3 1/2 microns + .005% 3 1/2 micr	L	micron and an average	
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curacy better than 2 1/2 microns plus .005% of fretance traverses. ILLEGIB	- Janaan	e Long Istance measurement goal is to proving an ac-	* *
On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: 2 1/2 micr ns or + 1 1/4 microns up to 1 millimeter. 3 1/2 microns or + 1 3/4 microns up to 20 millimeters. (System Accuracy: 2 1/2 microns + .005%)	7,7000	eatter than 2 1/2 microns plus .005% of distance travell	eđ.
On the basis of an accuracy analysis included below, believes the following accuracies can be achieved. STAT Specified System Total Accuracy: 2 1/2 micr ns or + 1 1/4 microns up to millimeter. 3 1/2 microns or + 1 3/4 microns up to 20 millimeters. (System Accuracy: 2 1/2 microns + .005%)	curacy c	etter than 2 2/2 mass	II I EGIR
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Specified System Total Accuracy: 2 1/2 micr ns or + 1 1/4 microns up to 1 millimeter. 3 1/2 microns or + 1 3/4 microns up to 20 millimeters. System Accuracy: 2 1/2 microns + .005%		On the basis of an accuracy analysis and he achieve	eđ.
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2 1/2 microns or + 1 1/4 microns up to 1 millimeter. 3 1/2 microns or + 1 3/4 microns up to 20 millimeters. (a) System Accuracy: (2 1/2 microns + .005%	•	Specified System Total Accuracy:	*
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3 1/2 microns or + 1 3/4 microns up to 20 millimeters. (System Accuracy: 2 1/2 microns + .005%		1/2 micr ns or + 1 1/4 microns up to	
3 1/2 microns or + 1 3/4 microns up to 20 millimeters. (3) System Accuracy: (2 1/2 microns + .005%		4 ' \ /	
20 millimeters. (System Accuracy: 2 1/2 microns + .005%		i millimeter.	
20 millimeters. (System Accuracy: 2 1/2 microns + .005%		y ···	
(5) System Accuracy: (2 1/2) microns + .005%	•	$\binom{3}{4}$ (3 1/2) microns or + 1 3/4 microns up to	•
(system Accuracy: 2 1/2 microns + .005%		20 millimeters.	
	·.		*
		Cyctem Accuracy (2 1/2 microns + .005%	
over distance traveried.			
		over distance travelier.	. 1
	_ ^h	proved For Release 2003/05/15 : CIA-RDP78B04747A003000020028-7	
Overall system repeatability within 1 3/4 microns.	^	Overall system repeatability within 1 3/4 microns.	

We are confident that the basic design of the Stereo viewer has sufficient rigidity to provide these, or greater, system accuracies.

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advancing the state of the art in large format stereo viewers, there is a high risk in etermining what the final accuracy will be. The exact results will not be known until the system is being tested.

applied. For example, has made the same type lead screw as is used on the viewer to an accuracy of 1/4m. Obtaining a guarantee to this is impossible.

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ACCURACY ANALYSIS

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LEAD SCREWS AND NUTS

2 1/2mm pitch accuracy specified as .000040 maximum lead error per inch, but not to exceed .0002 inch per foot of ball thread cumulative.

According to tests conducted by the manufacturer,
a total deviation .000040 inch per
inch is practical and is normally surpassed in order for the
manufacturer to qualify the overall tolerances. Actually,
has verified accuracies better than these
specified above for similar ball screws.

BALL BUSHINGS

These contain class 1 balls and are loaded to eliminate play. System effects due to eccentricity in the balls are expected to be lower than 5-10 millionths.

STRAIGHTNESS OF WAYS

The rod ways are obtained with an initial straightness of .0002 inch per foot. These will be further straightened by adjustment every six (6") inches across its length.

Straightness is expected to be better than .000030 inch per inch. Finematic design reduces this figure by a factor of two (2). Elasticity of final machined members has been predicted as being less. However, the aggregate elasticity of final system will not be known until completion.

HYSTERESIS AND DEFLECTION DUE TO VARIOUS FORCES FROM FIBER OFTIC CABLES, OFTICAL TURRETS, SCREWS, CARRIAGES AND WAYS STAT

Special efforts in Kinematic design have been made to provide low torque-flexible fiber optic cable coverings, rigidized mechanite castings, shortened lever arms and low hysteresis components as in house product improvements over previous designs. It is, therefore, estimated that approximately 1 1/2 microns will be contributed by these factors.

REPEATABILITY

Ball Screws

The rep		repea	eatability of the b			ball	all screws		in accordance					
with	these	tests	conduct	ted by				shc	ould	bе	in	the		STAT
ordei	of 10	0-20 m	illionth	ns.										

Ball Bushings

The effects of eccentricity and accuracy of the balls is 5-10 millionths. Hence, repeatability error due to the ball bushings is not expected to exceed 1/4 micron.

Hysteresis and Deflection Due to Various Forces on the Carriages

The repeatability error due to hysteresis and other effects is expected to be approximately one (1) micron.

532 Y TEN TOTAL ACCURACY RELATIVE TO DISTANCE TRAVELLED

O -1mm: 2 1/2 microns, or + 1 1/4 microns 20mm: 3 1/2 microns, or + 1 3/4 microns Approved For Release 2003/05/15: CIA-RDP78B04747A003000020028-7

552 SYSTEM REPEATABILITY

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Within 1 3/4 microns.

NOTE: The above system accuracy and repeatability does not include the accuracy of the digital readout system. Mowever, it does include any error due to connection between the output shaft and the digitizer. If the OPTISYN Encoder is used, then an additional + 1/4 counts error is added, as specified

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a measure of the individual operator's repeatability.

PROPOSED METHOD OF CHECKING ACCURACY AND REPEATABILITY

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ACCURACY CHECK

a master linear standard, certified by the National Sureau of Standards, to be calibrated within one (1) micron. An average of five (5) readings taken from one direction only will be recorded for each point on this calibrated grid to determine linear measurement accuracies. Grid was calibrated at 68 degrees F. If the est is made at other temperatures suitable thermocouples will be installed.

REPEATABILITY

or scale will be placed on the film platten. The operator will locate this point through the optics and note the coordinates. He will then move off the point and return to the same point for a total of rive (5) readings, always approaching from the same direction. The maximum difference of the five readings will be a measure of repeatability at this point. This procedure will be repeated at approximately six to ten different areas over each format.

also checking operator repeatability. The target will be selected where that is minimal. The repeatability of the operator can be checked by using a microscope with a filar eyepiece set to the same magnification of the system. A measurement can then be made on the same target by using the filar microscope, thus providing a measure of the individual operator's repeatability.

<u> </u>		WORK	STA	TEN	MENT	·	•
			And	l	ď		
INVESTIGATION	OF	PROBLEMS	ŢΟ	BE	ENCOUNTERED	IN	INSTALLING

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- A. Investigate feasibility of providing one (1) micron bit by direct coupling.
- B. 2 1/2mm precision ball screws will be provided.
- . Provide for Installation of Y Encoders: (See attached sketch)
 - 1. Redesign and revise layouts, parts drawing, patterns and castings, brackets and miscellaneous mounting components and hardware.
 - y carriage castings must be modified and relieved locally to accommodate casting tolerances in order to make clearance for movement tack and forth over the 2 3/4 inch diameter encoder.
 - 2. A carriage castings must be modified locally to fit 2 3/4 inch casting diameter of encoder. Also, rear rib/must be cut to clear this same diameter.
 - o. Special servo bracket to mount encoder. Extreme care and tolerances for zero backlash coupling of encoder to screw is required.
 - D. Provide for Installation of X Axis Encoders: (See attached sketch)

5. Checkout overall system operation.

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5. Debug and adjust for optimum performance.

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	castings, brackets and miscellaneous mounting components	
	and hardware.	
2	. Cut back base mounting pads.	
	Enlarge pad areas for mounting brackets.	
		•
4.	Type chester mounting bracket with close	· · ·
	tolerance and alignment care for mounting.	
•		
5,	Special extended shaft coupling zero backlash type.	
į i. i. Ir	ostallation - Checkout	
•		
Ι.	Install four (4) encoders (2 x and 2 y axis), customer	
-	supplied. Customer will furnish encoders wired for	OT 4 T
•	proper direction of count will specify	STAT
	which direction.	
2,	Channel and tie down cables form encoders. These customer	
	supplied cables must be approximately 18 to 20 feet long,	O T A T
	and properly shielded against interference with	STAT
	connectors to tie into counters.	STAT
,		
3,	Provide power cable 1100 60 cycles.	
4	Provide ON OFF	
·*.	switch and zero reset switch	
	control paner, with shielded wires and	STAT
• •	terminating connector and mating connector with 15 foot	
	of shielded wire, for paralleling System controls.	STAT
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CUSTOMER PROVIDED EQUIPMENT

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Customer will provide a complete measuring and readout system which will contain the following:

Pour (4) encoders, 2,500 counts per revolution, each with 18 to 20 foot of shielded cables.

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- B. Four (4) Said State counters, six (6) digit updown resettable to zero, with approximately 25kc
 count rate.
- C. Four (4) viewal display banks, uf six (6) digits, each with 20 foot cause, remote mountaing of desired.
- D. Enclosures and cabinets.
- E. Connectors and cables to equipment. STAT

 Types and lengths will be specified STAT